

LM26NV SOT-23, ±3°C Accurate, Factory Preset Thermostat (LM26 without V_{TEMP} output)

Check for Samples: LM26NV

FEATURES

- Internal Comparator with Pin Programmable 2°C or 10°C Hysteresis
- No External Components Required
- Open Drain or Push-Pull Digital Output; Supports CMOS Logic Levels
- Internal Temperature Sensor
- Internal Voltage Reference and DAC for Trip-Point Setting
- Currently Available in 5-Pin SOT-23 Plastic Package
- Excellent Power Supply Noise Rejection

APPLICATIONS

- Microprocessor Thermal Management
- Appliances
- Portable Battery Powered Systems
- Fan Control
- Industrial Process Control
- HVAC Systems
- Remote Temperature Sensing
- Electronic System Protection

KEY SPECIFICATIONS

- Power Supply Voltage: 2.7V to 5.5 V
- Power Supply Current:
 - $-40\mu A(max)$
 - 20µA(typ)
- Hysteresis Temperature: 2°C or 10°C(typ)

DESCRIPTION

The LM26NV is a precision, single digital-output, lowpower thermostat comprised of an internal reference, DAC, temperature sensor and comparator. Utilizing factory programming, it can be manufactured with different trip points as well as different digital output functionality. The trip point (T_{OS}) can be preset at the factory to any temperature in the range of -55°C to +110°C in 1°C increments. The LM26NV has one digital output (OS/OS/US/US) and one digital input (HYST). The digital output stage can be preset as either open-drain or push-pull. In addition, it can be factory programmed to be active HIGH or LOW. The digital output can be factory programmed to indicate an over temperature shutdown event (OS or \overline{OS}) or an under temperature shutdown event (US or US). When preset as an overtemperature shutdown (OS), it will go LOW to indicate that the die temperature is over the internally preset Tos and go HIGH when the temperature goes below (T_{OS} - T_{HYST}). Similarly, when preprogrammed as an undertemperature shutdown (US) it will go HIGH to indicate that the temperature is below T_{US} and go LOW when the temperature is above (T_{US}+T_{HYST}). The typical hysteresis, T_{HYST}, can be set to 2°C or 10°C and is controlled by the state of the HYST pin.

Available parts are detailed in the ordering information. For other part options, contact a Texas Instruments Distributor or Sales Representative for information on minimum order qualification. The LM26NV is currently available in a 5-lead SOT-23 package.

Table 1. Temperature Trip Point Accuracy

Temperature Range	LM26NV
-55°C to +110°C	±3°C (max)
+120°C	±4°C (max)

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Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



Connection Diagram

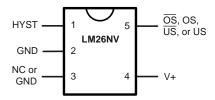


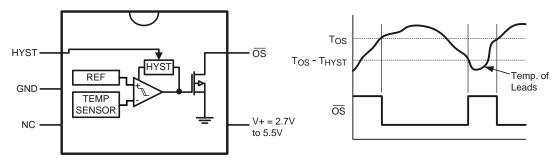
Figure 1. 5-Lead SOT-23 See DBV Package

PIN DESCRIPTIONS

Pin Number	Pin Name	Function	Connection			
1	HYST	Hysteresis control, digital input	GND for 10°C or V ⁺ for 2°C			
2	GND	GND Ground, connected to the back side of the die through lead frame. System GND				
3	NC	Not Connected Inside Part	Ground or No Connect			
4	V ⁺	Supply input	2.7V to 5.5V with a 0.1µF bypass capacitor. For PSRR information see <i>Section Titled NOISE CONSIDERATIONS</i> .			
5 ⁽¹⁾	ŌS	Overtemperature Shutdown open-drain active low thermostat digital output	Controller interrupt, system or power supply shutdown; pull-up resistor $\geq 10 k\Omega$			
	os	Overtemperature Shutdown push-pull active high thermostat digital output	Controller interrupt, system or power supply shutdown			
	Undertemperature Shutdown open-drain active S low thermostat digital output		System or power supply shutdown; pull-up resistor ≥ 10kΩ			
	US	Undertemperature Shutdown push-pull active high thermostat digital output	System or power supply shutdown			

(1) Pin 5 functionality and trip point setting are programmed during LM26NV manufacture.

LM26CIM5-YPE Simplified Block Diagram and Connection Diagram



HYST = GND for 10℃ Hysteresis HYST = V+ for 2℃ Hysteresis

The LM26CIM5-YPE has a fixed trip point of 115°C. For other trip point and output function availability, please see ordering information or contact Texas Instruments.

Figure 2.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

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Absolute Maximum Ratings (1)

Input Voltage	6.0V	
Input Current at any pin (2)	5mA	
Package Input Current ⁽²⁾		20mA
Package Dissipation at T _A = 25°C ⁽³⁾	500mW	
Soldering Information (4)		
SOT-23 Package	Vapor Phase (60 seconds)	215°C
	Infrared (15 seconds)	220°C
Storage Temperature		−65°C to + 150°C
ESD Susceptibility (5)	Human Body Model	2500V
	Machine Model	250V

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. For ensured specifications and test conditions, see the Electrical Characteristics. The ensured specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.
- (2) When the input voltage (V_I) at any pin exceeds the power supply (V_I < GND or V_I > V⁺), the current at that pin should be limited to 5mA. The 20mA maximum package input current rating limits the number of pins that can safely exceed the power supplies with an input current of 5mA to four. Under normal operating conditions the maximum current that pins 2, 4 or 5 can handle is limited to 5mA each.
- (3) The maximum power dissipation must be derated at elevated temperatures and is dictated by T_{Jmax} (maximum junction temperature), θ_{JA} (junction to ambient thermal resistance) and T_A (ambient temperature). The maximum allowable power dissipation at any temperature is P_D = (T_{Jmax}-T_A)/θ_{JA} or the number given in the Absolute Maximum Ratings, whichever is lower. For this device, T_{Jmax} = 150°C. For this device the typical thermal resistance (θ_{JA}) of the different package types when board mounted follow:
- (4) See the URL "http://www.ti.com/packaging" for other recommendations and methods of soldering surface mount devices.
- (5) The human body model is a 100pF capacitor discharge through a 1.5kΩ resistor into each pin. The machine model is a 200pF capacitor discharged directly into each pin.

Operating Ratings (1)

-	
Specified Temperature Range	$T_{MIN} \le T_A \le T_{MAX}$
LM26NV	-55°C ≤ T _A ≤ +125°C
Positive Supply Voltage (V ⁺)	+2.7V to +5.5V
Maximum V _{OUT}	+5.5V

(1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. For ensured specifications and test conditions, see the Electrical Characteristics. The ensured specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

Product Folder Links: LM26NV



LM26NV Electrical Characteristics

The following specifications apply for $V^+ = 2.7 V_{DC}$ to $5.5 V_{DC}$, and V_{TEMP} load current = $0\mu A$ unless otherwise specified. **Boldface limits apply for T_A = T_J = T_{MIN} to T_{MAX}**; all other limits T_A = T_J = 25° C unless otherwise specified.

Symbol	Parameter	Conditions	Typical ⁽¹⁾	LM26NV Limits	Units (Limits)
Temperature	Sensor		L		
	Trip Point Accuracy (Includes V _{REF} , DAC,	-55°C ≤ T _A ≤ +110°C		±3	°C (max)
	Comparator Offset, and Temperature Sensitivity errors)	+120°C		±4	°C (max)
	Trip Point Hysteresis	HYST = GND	11		°C
		HYST = V ⁺	2		°C
I _S	Supply Current		16	20 40	μΑ (max) μΑ (max)
Digital Outpo	ut and Input				
I _{OUT("1")}	Logical "1" Output Leakage Current (3)	V ⁺ = +5.0V	0.001	1	μA (max)
V _{OUT("0")}	Logical "0" Output Voltage	I_{OUT} = +1.2mA and $V^{+} \ge 2.7V$; I_{OUT} = +3.2mA and $V^{+} \ge 4.5V$; ⁽⁴⁾		0.4	V (max)
V _{OUT("1")}	Logical "1" Push-Pull Output Voltage	I _{SOURCE} = 500μA, V ⁺ ≥ 2.7V		0.8 × V ⁺	V (min)
		I _{SOURCE} = 800μA, V ⁺ ≥4.5V		V ⁺ - 1.5	V (min)
V _{IH}	HYST Input Logical "1" Threshold Voltage			0.8 × V ⁺	V (min)
V_{IL}	HYST Input Logical "0" Threshold Voltage			0.2 × V ⁺	V (max)

- (1) Typicals are at $T_J = T_A = 25^{\circ}\text{C}$ and represent most likely parametric norm.
- (2) Limits are ensured to AOQL (Average Outgoing Quality Level).
- (3) The 1µA limit is based on a testing limitation and does not reflect the actual performance of the part. Expect to see a doubling of the current for every 15°C increase in temperature. For example, the 1nA typical current at 25°C would increase to 16nA at 85°C.
 (4) Care should be taken to include the effects of self heating when setting the maximum output load current. The power dissipation of the
- (4) Care should be taken to include the effects of self heating when setting the maximum output load current. The power dissipation of the LM26NV would increase by 1.28mW when I_{OUT}=3.2mA and V_{OUT}=0.4V. With a thermal resistance of 250°C/W, this power dissipation would cause an increase in the die temperature of about 0.32°C due to self heating. Self heating is not included in the trip point accuracy specification.

Package Type	θ_{JA}
SOT-23, DBV	250°C/W

Part Number Template

The series of characters labeled "xyz" in the part number LM26CIM5-xyz, describe the set point value and the function of the output. The character at "x" and "y" define the set point temperature (at which the digital output will go active). The "z" character defines the type and function of the digital output. These place holders are defined in the following tables.

The place holders xy describe the set point temperature as shown in the following table.

x (10x)	y (1x)	Temperature (°C)
Α	-	- 5
В	-	-4
С	-	-3
D	-	-2
E	-	-1
F	-	-0
Н	Н	0
J	J	1
К	К	2
L	L	3

Product Folder Links: LM26NV



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x (10x)	y (1x)	Temperature (°C)
N	N	4
Р	Р	5
R	R	6
S	S	7
Т	Т	8
V	V	9
Х	-	10
Y	-	11
Z	-	12

The value of z describes the assignment/function of the output as shown in the following table:

Active-Low/High	Open-Drain/ Push- Pull	OS/US	Value of z	Digital Output Function
0	0	0	E	Active-Low, Open-Drain, OS output
0	0	1	F	Active-Low, Open-Drain, US output
1	1	0	G	Active-High, Push-Pull, OS output
1	1	1	Н	Active-High, Push-Pull, US output

EXAMPLE:

• The part number LM26CIM5-YPE has $T_{OS} = 115^{\circ}C$, and has an active-low open-drain overtemperature shutdown output. The "Y" represents the tens value "11", the "P" represents the ones value "5", and the "E" means that the output will be an active-low, open-drain, over-temperature output.

Many active-high open-drain and active-low push-pull options are available, please contact Texas Instruments for more information.

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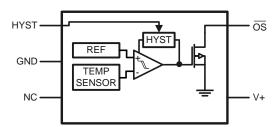


FUNCTIONAL DESCRIPTION

LM26NV OPTIONS

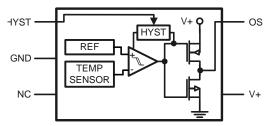
The LM26NV can be factory programmed to have a trip point anywhere in the range of −55°C to +110°C. It is also available in any of four output options, as indicated by the last letter in the part number.

Output Pin Options Block Diagrams



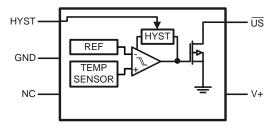
The "E" in "LM26CIM5 - _ _ E " indicates that the digital output is Active-Low Open-Drain and will trip as temperature is rising (OS)

Figure 3. LM26CIM5 - _ _ E



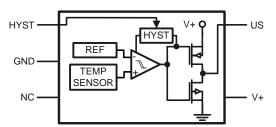
The "G" in "LM26CIM5 - _ _G " indicates that the digital output is Active-High Push-Pull and will trip as temperature is rising (OS)

Figure 5. LM26CIM5 - _ _G



The "F" in "LM26CIM5 - _ _ F " indicates that the digital output is Active-Low Open-Drain and will trip as temperature is falling (US)

Figure 4. LM26CIM5 - _ _ F



The "H" in "LM26CIM5 - _ _H" indicates that the digital output is Active-High Push-Pull and will trip as temperature is falling (US)

Figure 6. LM26CIM5 - H

Applications Hints

NOISE CONSIDERATIONS

The LM26NV has excellent power supply noise rejection. Listed below is a variety of signals used to test the LM26NV power supply rejection. False triggering of the output was not observed when these signals where coupled into the V+ pin of the LM26NV.

- Square Wave 400kHz, 1Vp-p
- Square Wave 2kHz, 200mVp-p
- Sine Wave 100Hz to 1MHz, 200mVp-p

Testing was done while maintaining the temperature of the LM26NV one degree centigrade way from the trip point with the output not activated.



MOUNTING CONSIDERATIONS

The LM26NV can be applied easily in the same way as other integrated-circuit temperature sensors. It can be glued or cemented to a surface. The temperature that the LM26NV is sensing will be within about +0.06°C of the surface temperature to which the LM26NV's leads are attached to.

This presumes that the ambient air temperature is almost the same as the surface temperature; if the air temperature were much higher or lower than the surface temperature, the actual temperature measured would be at an intermediate temperature between the surface temperature and the air temperature.

To ensure good thermal conductivity, the backside of the LM26NV die is directly attached to the GND pin (pin 2). The temperatures of the lands and traces to the other leads of the LM26NV will also affect the temperature that is being sensed.

Alternatively, the LM26NV can be mounted inside a sealed-end metal tube, and can then be dipped into a bath or screwed into a threaded hole in a tank. As with any IC, the LM26NV and accompanying wiring and circuits must be kept insulated and dry, to avoid leakage and corrosion. This is especially true if the circuit may operate at cold temperatures where condensation can occur. Printed-circuit coatings and varnishes such as Humiseal and epoxy paints or dips are often used to ensure that moisture cannot corrode the LM26NV or its connections.

The junction to ambient thermal resistance (θ_{JA}) is the parameter used to calculate the rise of a part's junction temperature due to its power dissipation. For the LM26NV the equation used to calculate the rise in the die junction temperature is as follows:

$$T_{J} = T_{A} + \Theta_{JA}(V^{\dagger}I_{Q} + V_{DO}I_{DO})$$

where

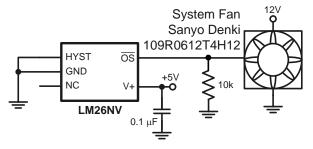
- T_A is the ambient temperature
- V⁺ is the power supply voltage
- I_O is the quiescent current
- V_{DO} is the voltage on the digital output
- I_{DO} is the load current on the digital output

Table 2 summarizes the thermal resistance for different conditions and the rise in die temperature of the LM26NV and a 10k pull-up resistor on an open-drain digital output with a 5.5V power supply.

Table 2. Thermal resistance (θ_{JA}) and temperature rise due to self heating ($T_J - T_A$)

	•	•		•	
		T-23 eat sink	SOT-23 small heat sink		
	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$				
Still Air	250	0.11	TBD	TBD	
Moving Air	TBD	TBD	TBD	TBD	

Typical Applications



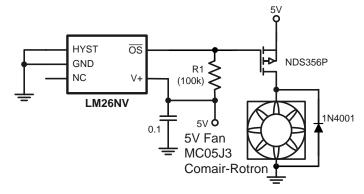
The fan's control pin has an internal pull-up. The 10 kOhm pull-down sets a slow fan speed. When the output of the LM26NV goes low, the fan will speed up.

Figure 7. Two Speed Fan Speed Control

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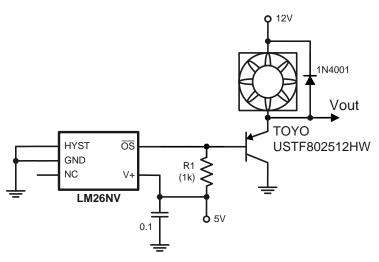
(1)





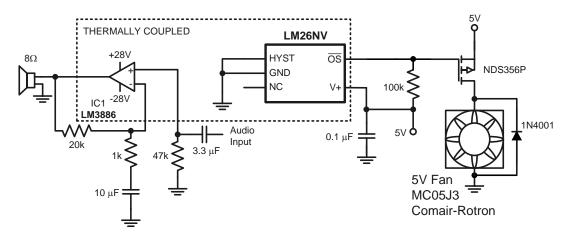
The LM26NV switches the fan on when the measured temperature exceeds the trip temperature.

Figure 8. Fan High Side Drive



The LM26LV sinks causes the switch to sink the fan current when the measured temperature exceeds the trip temperature.

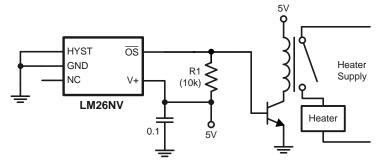
Figure 9. Fan Low Side Drive



By thermally coupling the LM26NV to the audio power amplifier, the LM26NV safeguards the amplifier from overheating, turning on the fan when it temperature exceeds the trip temperature.

Figure 10. Audio Power Amplifier Thermal Protection





When the measured temperature is below the trip temperature of the LM26NV, the \overline{OS} output will be high, causing the switch and relay to close. When the temperature exceeds the trip point, \overline{OS} goes low and shuts off the relay and heater.

Figure 11. Simple Thermostat



REVISION HISTORY

Cł	hanges from Revision A (March 2013) to Revision B	Page
•	Changed layout of National Data Sheet to TI format	9



PACKAGE OPTION ADDENDUM

5-Feb-2014

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
LM26CIM5-YPE/NOPB	ACTIVE	SOT-23	DBV	5	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-55 to 125	TYPE	Samples
LM26CIM5X-YPE/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-55 to 125	TYPE	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

5-Feb-2014

In no event shall TI's liabilit	ty arising out of such information	exceed the total purchase price	ce of the TI part(s) at issue in th	is document sold by TI to Cu	stomer on an annual basis.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LM26CIM5-YPE/NOPB	SOT-23	DBV	5	1000	179.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LM26CIM5X-YPE/NOPB	SOT-23	DBV	5	3000	179.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LM26CIM5-YPE/NOPB	SOT-23	DBV	5	1000	203.0	203.0	35.0
LM26CIM5X-YPE/NOPB	SOT-23	DBV	5	3000	203.0	203.0	35.0

DBV (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-178 Variation AA.



DBV (R-PDSO-G5)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



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